

Notice of References Cited	Application/Control No. 10/689,257	Applicant(s)/Patent Under Reexamination BEAUMONT, MARK	
	Examiner David J. Huisman	Art Unit 2183	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0054870	03-2004	Kirsch, Graham	712/011
*	B	US-6,023,753	02-2000	Pechanek et al.	712/18
	C	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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